



DEBUG IN HIGH DEFINITION



HDO4000A

200 MHz - 1 GHz Oscilloscopes



Lowest Noise and Powerful Toolbox

HD4096 Technology

Superior User Experience

Powerful, Deep Toolbox

Exceptional Serial Data Tools

The HDO4000A with HD4096 Technology provides exceptional signal fidelity with 12-bit resolution and a superior oscilloscope experience to deliver faster time to insight.

DEBUG IN HIGH DEFINITION

High Definition Oscilloscopes with HD Technology have a variety of benefits that allow the user to debug in high definition. Waveforms displayed by High Definition Oscilloscopes are cleaner and crisper. More signal details can be seen and measured; these measurements are made with unmatched precision resulting in better test results and shorter debug time.





Experience HD4096 accuracy, detail, and precision and never use an 8-bit oscilloscope again. Whether the application is general-purpose design and debug, high-precision analog, power electronics, automotive electronics, mechatronics, or other specialized applications, the HD4096 technology provides unsurpassed confidence and measurement capabilities.

Clean, Crisp Waveforms

When compared to waveforms acquired and displayed using conventional 8-bit oscilloscopes, waveforms captured with HD4096 12-bit technology are dramatically crisper and cleaner, and are displayed more accurately.

More Signal Details

16x more resolution provides more signal detail. This is especially helpful for wide dynamic range signals in which a full-scale signal must be acquired while at the same time very small amplitude signal details must be analyzed.

Unmatched Measurement Precision

HD4096 technology delivers measurement precision several times better than conventional 8-bit oscilloscopes. Higher oscilloscope measurement precision provides better ability to assess corner cases and design margins, perform root cause analysis, and create the best possible solution for any discovered design issue.



	HDO4000A	HD06000A	HD08000A	HDO9000
HD Technology	HD4096 12 bits	HD4096 12 bits	HD4096 12 bits	HD1024 10 bits
Bandwidth	200 MHz - 1 GHz	350 MHz - 1 GHz	350 MHz - 1 GHz	1 GHz - 4 GHz
Input Channels	4	4	8	4
Sample Rate	10 GS/s	10 GS/s	10 GS/s	40 GS/s
Standard Toolbox	Basic	Advanced	Advanced	Advanced
Serial Data Tools	TD	TDME	TDME	TDME, SDAII, QPHY
User Experience	MAUI with OneTouch	MAUI with OneTouch	MAUI with OneTouch	MAUI with OneTouch



HD1024 technology provides 10 bits of vertical resolution with 4 GHz bandwidth. As with all members of Teledyne LeCroy's HDO family, the HDO9000 utilizes an exceptionally low-noise system architecture that delivers outstanding effective number of bits (ENOB). Dynamic ADC Configuration permits the ADC to be set to 8, 9, or 10 bits. Optimized filtering provides additional resolution beyond 10 bits (extending up to 13.8 bits).



DEBUG IN HIGH DEFINITION

Lowest Noise and Powerful Toolbox



High Signal to **Noise Input**

Amplifiers

High Sample

Rate 12-bit

ADC's

Low Noise System Architecture

HD4096 technology enables 12 bits of vertical resolution with 1 GHz bandwidth

- Clean, Crisp Waveforms
- More Signal Details
- Unmatched Measurement Precision

Toolbox

OBSESSED WITH TOOLS HDO4000A has the greatest breadth and depth of tools, ensuring guick resolution of the most complicated debug tasks.

The HDO4000A with HD4096 Technology provides exceptional signal fidelity with 12-bit resolution and a superior oscilloscope experience to deliver faster time to insight.

- 1 HD4096 Technology
- 2 Superior User Experience
- 3 Powerful, Deep Toolbox
- Exceptional Serial Data Tools



Faster Time to Insight

Insight alone is not enough.

Markets and technologies change too rapidly.

The **timing** of **critical design** decisions is significant.

Faster Time to Insight is what matters.



MAUI® - SUPERIOR USER EXPERIENCE



MAUI – Most Advanced User Interface was developed to put all the power and capabilities of the modern oscilloscope right at your fingertips. Designed for touch; all important oscilloscope controls are accessed through the intuitive touch screen. Built for simplicity; time saving shortcuts and intuitive dialogs simplify setup. Made to solve; a deep set of debug and analysis tools helps identify problems and find solutions quickly.

Designed for Touch

MAUI is designed for touch. Operate the oscilloscope just like a phone or tablet with the most unique touch screen features on any oscilloscope. All important controls are always one touch away. Touch the waveform to position or zoom in for more details using intuitive actions.

Built for Simplicity

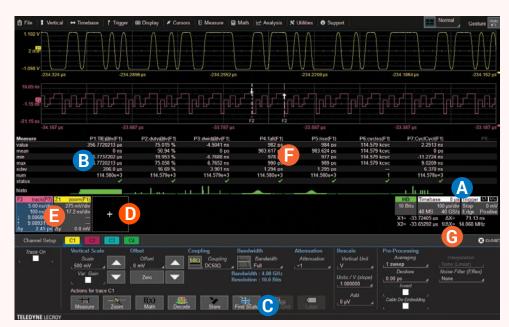
MAUI is built for simplicity. Basic waveform viewing and measurement tools as well as advanced math and analysis capabilities are seamlessly integrated in a single user interface. Time saving shortcuts and intuitive dialogs simplify setup and shorten debug time.

Made to Solve

MAUI is made to solve. A deep set of integrated debug and analysis tools help identify problems and find solutions quickly. Unsurpassed integration provides critical flexibility when debugging. Solve problems fast with powerful analysis tools.

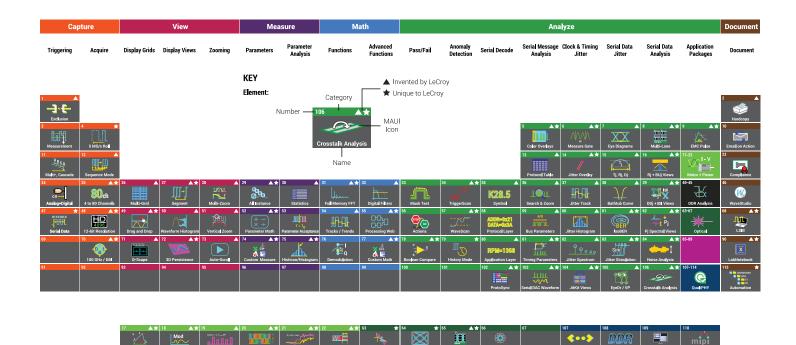
MAUI with OneTouch

MAUI with OneTouch introduces a new paradigm for oscilloscope user experience. Dramatically reduce setup time with revolutionary drag and drop actions to copy and setup channels, math functions, and measurement parameters without lifting a finger. Use common gestures like drag, drop, and flick to instinctively interact with the oscilloscope. Quickly enable a new channel, math or measurement using the "Add New" button and simply turn off any trace with a flick of the finger. These OneTouch innovations provide unsurpassed efficiency in oscilloscope operation.



- A Channel, timebase, and trigger descriptors provide easy access to controls without navigating menus.
- Configure parameters by touching measurement results.
- Shortcuts to commonly used functions are displayed at the bottom of the channel, math and memory menus.
- Use the "Add New" button for one-touch trace creation.
- Drag to change source, copy setup, turn on new trace, or move waveform location.
- Drag to copy measurement parameters to streamline setup process.
- Drag to quickly position cursors on a trace.

POWERFUL, DEEP TOOLBOX



Our Heritage

Teledyne LeCroy's 50+ year heritage has its origins in the high-speed collection of data in the field of high-energy physics, and the processing of long records to extract meaningful insight. We didn't invent the oscilloscope, but we did invent the digital oscilloscope, which can take full advantage of advanced digital signal processing and waveshape analysis tools to provide unparalleled insight.

Our Obsession

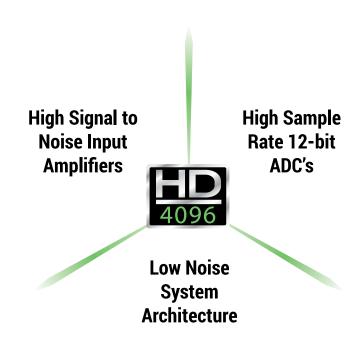
Our developers are true to our heritage – they are more obsessed with making better and smarter tools than anybody else. Our tools and operating philosophy are standardized across much of our product line for a consistent user experience. Our mission is to help you use these tools to understand problems, including the ones you don't even know you have. Our deep toolbox inspires insight; and your moment of insight is our reward

Our Invitation

Our Periodic Table of Oscilloscope
Tools provides a framework to
understand the toolsets that Teledyne
LeCroy has created and deployed in
our oscilloscopes. Visit our interactive
website to learn more about what we
offer and how we can help you develop
and debug more efficiently.

teledynelecroy.com/tools

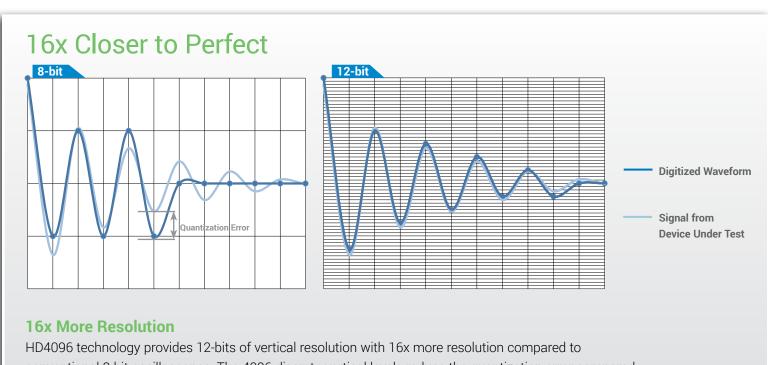
HD4096 TECHNOLOGY - 16X CLOSER TO PERFECT



Teledyne LeCroy HDO high definition oscilloscopes use unique HD4096 technology to provide superior and uncompromised measurement performance:

- 12-bit ADCs with high sample rates
- High signal-to-noise amplifiers (55 dB)
- Low noise system architecture (to 1 GHz)

Oscilloscopes with HD4096 technology have higher resolution than conventional 8-bit oscilloscopes (4096 vs. 256 vertical levels) and low noise for uncompromised measurement performance. The 12-bit ADCs support capture of fast signals and oscilloscope bandwidth ratings up to 1 GHz, and Enhanced Sample Rate to 10 GS/s ensures the highest measurement accuracy and precision. The high performance input amplifiers deliver pristine signal fidelity with a 55 dB signal-to-noise ratio. The low-noise system architecture provides an ideal signal path to ensure that signal details are delivered accurately to the oscilloscope display – 16x closer to perfect.



HD4096 technology provides 12-bits of vertical resolution with 16x more resolution compared to conventional 8-bit oscilloscopes. The 4096 discrete vertical levels reduce the quantization error compared to 256 vertical levels. This improves the accuracy and precision of the signal capture and increases measurement confidence.

EXPERIENCE THE DIFFERENCE



Experience HD4096 accuracy, detail, and precision and never use an 8-bit oscilloscope again. Whether the application is general-purpose design and debug, high-precision analog, power electronics, automotive electronics, mechatronics, or other specialized applications, the HD4096 technology provides unsurpassed confidence and measurement capabilities.

Clean, Crisp Waveforms

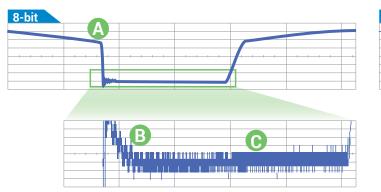
When compared to waveforms acquired and displayed using conventional 8-bit oscilloscopes, waveforms captured with HD4096 12-bit technology are dramatically crisper and cleaner, and are displayed more accurately. Once you see a waveform acquired with HD4096 technology, you will not want to go back to using a conventional 8-bit oscilloscope.

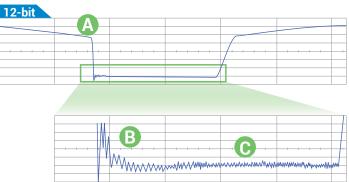
More Signal Details

16x more resolution provides more signal detail. This is especially helpful for wide dynamic range signals in which a full-scale signal must be acquired while at the same time very small amplitude signal details must be analyzed. 12-bit acquisitions combined with the oscilloscope's vertical and horizontal zoom can be used to obtain unparalleled insight to system behaviors and problems.

Unmatched Measurement Precision

HD4096 technology delivers measurement precision several times better than conventional 8-bit oscilloscopes. Higher oscilloscope measurement precision provides better ability to assess corner cases and design margins, perform root cause analysis, and create the best possible solution for any discovered design issue.





- A Clean, Crisp Waveforms | Thin traces show the actual waveform with minimal noise interference
- **More Signal Details** | Waveform details lost on an 8-bit oscilloscope can now be clearly seen
- Unmatched Measurement Precision | Measurements are more precise and not affected by quantization noise

HDO4000A AT A GLANCE



HDO4000A oscilloscopes have 4 analog input channels, 12-bit resolution using Teledyne LeCroy's HD4096 high definition technology, up to 1 GHz of bandwidth and a compact form factor with a large 12.1" multi-touch display. They are ideal for debug and troubleshooting of power electronics designs, digital power management or power integrity analysis, automotive electronics systems, and deeply embedded or mechatronic designs.

Key Features

4 analog channels

12-bit ADC resolution, up to 15-bit with enhanced resolution

200 MHz, 350 MHz, 500 MHz and 1 GHz bandwidths

Long Memory – up to 50 Mpts

Multi-language User Interface

WaveScan - Search and Find

LabNotebook Documentation and Report Generation

History Mode

Spectrum Analyzer Mode

Power Analysis Software

16 Digital Channel MSO option

Serial Trigger and Decode options

12.1" WXGA multi-touch screen display

Wide probe selection for power electronics, embedded electronics, and mechatronics applications



Power Electronics

Measure single-device(s), half, or Full/H-bridge outputs, including gate-drive voltages. Measure device loss or switch-mode power supply power or control loop performance, including line harmonics. The best performing HV probes support full characterization of all aspects of the power conversion system.

Automotive Electronics

Automotive electronic control units (ECUs) are tested to stringent standards. 12-bits and 250 Mpts provides the amplitude and time resolution needed for better and more intuitive cause-effect analog signal analysis. Deep digital logic capture and extensive serial data toolsets provides an all-in-one characterization tool for the complex, dynamic behavior of the vehicle ECUs.









Digital Power Management, Power Integrity

12-bit accuracy and precision and 1 GHz of bandwidth is perfect for transient rail response, rail voltage power integrity, crosstalk and harmonics evaluation. Specialized probes, analysis software, and serial decoders make fast work of complex embedded system power management and integrity validation.

Deeply Embedded and Mechatronic Systems

Today's consumer appliances and industrial systems combine complex embedded controls, power electronics, and sensors to achieve the highest efficiency and provide important control and other benefits. Time-to-market, cost and quality pressures place exceptional demands on new product test, debug and troubleshooting.

- Only 13 cm (5") Deep The most space-efficient oscilloscope for your bench from 200 MHz to 1 GHz
- 2 12.1" Widescreen (16 x 9) high resolution WXGA color multi-touch screen display.
- Built-in stylus for touch screen
- 4 Local language user interface front panel overlay
- "Push" Knobs All knobs have push functionality that provides shortcuts to common actions such as Set to Variable, Find Trigger Level, Zero Offset, and Zero Delay
- 6 Waveform Control Knobs for channel, zoom, math and memory traces
- 7 Dedicated buttons to quickly access popular debug tools
- 8 Easy connectivity with two convenient USB ports on the front, two on the side
- Mixed Signal Capability Debug complex embedded designs with integrated 16 channel mixed signal capability
- Rotating and Tilting Feet provide 4 different viewing positions
- Auxiliary Output and Reference
 Clock Input/Output connectors for
 connecting to other equipment
- USBTMC (Test and Measurement Class) port simplifies programming

POWERFUL MIXED SIGNAL CAPABILITIES



The HDO4000A High Definition Oscilloscopes offer powerful mixed signal solutions that combine high definition analog channels with the flexibility of digital inputs. The HDO4000A-MS options provide an integrated 16 digital channels and a 1.25 GS/s sampling rate to create an all-in-one debug machine.

Integrated 16-Channel Mixed Signal Capability

With embedded systems growing more complex, powerful mixed signal debug capabilities are an essential part of modern oscilloscopes. The 16 integrated digital channels and set of tools designed to view, measure and analyze analog and digital signals enable fast debugging of mixed signal designs.

Extensive Triggering

Flexible analog and digital cross-pattern triggering across all 20 channels provides the ability to quickly identify and isolate problems in an embedded system. Event triggering can be configured to arm on an analog signal and trigger on a digital pattern.

Advanced Digital Debug Tools

Using the powerful parallel pattern search capability of WaveScan, patterns across many digital lines can be isolated and analyzed. Identified patterns are presented in a table with timestamp information and enables quick searching for each pattern occurrence.

Use a variety of the many timing parameters to measure and analyze the characteristics of digital busses. Powerful tools like tracks, trends, statistics and histicons provide additional insight and help find anomalies.

Quickly see the state of all the digital lines at the same time using convenient activity indicators.



STANDARD TOOLS FOR ADVANCED ANALYSIS





WaveScan Advanced Search

WaveScan provides powerful isolation capabilities that hardware triggers can't provide. WaveScan allows searching analog, digital or parallel bus signal in a single acquisition using more than 20 different criteria. Or, set up a scan condition and scan for an event over hours or even days.

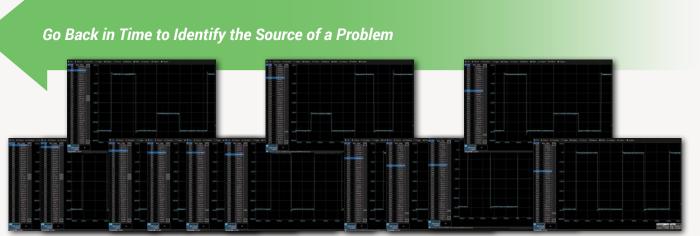


Advanced Math and Measure

With many math functions and measurement parameters available, the HDO4000A can measure and analyze every aspect of analog and digital waveforms. By utilizing HD4096 technology, the HDO4000A measures 16 times more precisely than traditional 8-bit architectures. Additionally, the HDO4000A provides statistics, histicons and trends to show how waveforms change over time.

History Mode Waveform Playback

Scroll back in time using History Mode to view previous waveforms and isolate anomalies. Use cursors and measurement parameters to quickly find the source of problems. History mode is always available with a single button press, no need to enable this mode and never miss a waveform.

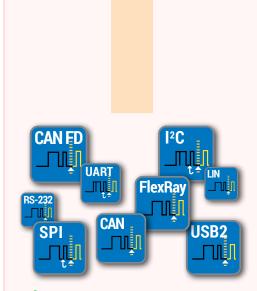


EXCEPTIONAL SERIAL DATA TOOLS

The HDO4000A features the widest range and most complete serial data debug toolsets.

- Triggering
- Decoding

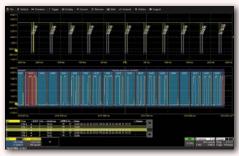
	HDO4000A Serial Data Protocol Support	Trigger	Decode	
	I ² C	•	•	
ddec	SPI	•	•	
Embedded Computing	UART-RS232	•	•	
шО	USB2-HSIC		•	
trial	CAN	•	•	
Automotive + Industrial	CAN FD	•	•	
/e +	FlexRay	•	•	
moti	LIN	•	•	
Auto	SENT		•	
	ARINC429		•	
Avionics	MIL-STD-1553	•	•	
Ą	SPACEWIRE		•	
g 8 8	Ethernet (10/100Base-T)		•	
puting pherals	MDIO		•	
Com + Perij	USB 1.1/2.0	•	•	
-+	8b/10b	•	•	
MIPI	D-PHY/CSI-2/DSI		•	
	DigRF3G		•	
	DigRFv4		•	
	SPMI		•	
	Audio (I ² S, LJ, RJ, TDM)	•	•	
Other	Manchester		•	
0	NRZ	•	•	



Trigger

Powerful, flexible triggers designed by people who know the standards, with the unique capabilities you want to isolate unusual events. Conditional data triggering permits maximum flexibility and highly adaptable error frame triggering is available to isolate error conditions. Efficiently acquire bursted data using Sequence Mode to maximize the oscilloscope's memory usage. Sequence Mode enables the oscilloscope to ignore idle time and acquire only data of interest.





Decode

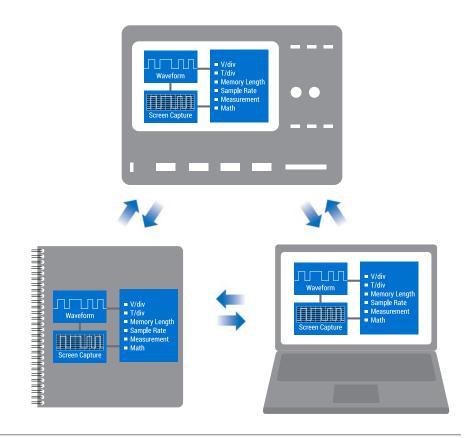
Decoded protocol information is color-coded to specific portions of the serial data waveform and transparently overlaid for an intuitive, easy-to-understand visual record. All decoded protocols are displayed in a single time-interleaved table. Touch a row in the interactive table to quickly zoom to a packet of interest and select a column header to create filter criteria, as is commonly done in spreadsheets. Easily search through long records for specific protocol events using the builtin search feature.

DOCUMENTATION AND SEQUENCE MODE



LabNotebook Documentation Tool

LabNotebook is a standard feature of HDO4000A and is the ideal documentation tool. LabNotebook automatically saves all displayed waveforms, oscilloscope setup file, and a screen image with a single button press, eliminating the need to navigate multiple menus to save all these files independently. Report files can be annotated and shared with colleagues to fully document all results. Easily recreate experiments and compare tests results amongst colleagues across the world by recalling LabNotebook files back onto the oscilloscope or view on a PC using WaveStudio.



Advanced Waveform Capture with **Sequence Mode**

Use Sequence mode to store up to 10,000 triggered events as segments. This is ideal when capturing fast pulses in quick succession or when capturing events separated by long time periods. Each segment has a timestamp and dead-time between triggers is less than 1 μ s. Isolate rate events over time by combining with advanced triggers.



SPECTRUM ANALYZER OPTION



Key Features

Spectrum analyzer style controls for the oscilloscope

Dual Spectrum Capability

Select from six vertical scales (in dB, V, or A)

Automatic frequency peak identifications

Display up to 20 markers, with interactive table readout of frequencies and levels

Easily make measurements with reference and delta markers

Automatically identify and mark fundamental frequency and harmonics

Spectrogram shows how spectra changes over time in 2D or 3D views



Use two independent input settings and frequency ranges for advanced spectrum analysis.

Simplify Analysis of FFT Power Spectrum

Get faster and better insight to the frequency content of any signal with use of the Spectrum Analyzer mode on the HDO4000A. This mode provides a spectrum analyzer style user interface with controls for start/stop frequency or center frequency and span. The resolution bandwidth is automatically set for best analysis or can be manually selected. Peak search automatically labels spectral components and presents frequency and level in an interactive table. Utilize up to 20 markers to automatically identify harmonics and quickly analyze frequency content by making measurements between reference and delta markers. Spectrograms display a 2D or 3D history of the frequency content to provided insight into how the spectrum changes over time.



Spectrum analyzer style controls simplify waveform analysis in the frequency domain.

POWER ANALYSIS OPTION



Key Features

Automated measurement zone identification with color-coded overlays

Control loop and time domain response analysis

Line power and harmonics tests to IEC 61000-3-2

Total harmonic distortion table shows frequency contribution

B-H Curve shows magnetic device saturation

Power Analyzer Automates Switching Device Loss Measurements

Quickly measure and analyze the operating characteristics of power conversion devices and circuits with the Power Analyzer option. Critical power switching device measurements, control loop modulation analysis, and line power harmonic testing are all simplified with a dedicated user interface and automatic measurements. Areas of turn-on, turn-off, and conduction loss are all identified with color-coded waveform overlays for faster analysis.

Power Analyzer provides quick and easy setup of voltage and current inputs and makes measurements as simple as the push of a button. Tools are provided to help reduce sources of measurement errors and the measurement parameters provide details of single cycle or average device power losses.

Beyond the advanced power loss measurement capabilities, the Power Analyzer modulation analysis capabilities provide insight to understand control loop response to critical events such as a power supply's soft start performance or step response to line and load changes. The Line Power Analysis tool allows simple and quick pre-compliance testing to EN 61000-3-2.

PROBES



Teledyne LeCroy offers an extensive range of probes to meet virtually every probing need.

ZS Series High Impedance Active Probes

ZS1000, ZS1000-QUADPAK ZS1500, ZS1500-QUADPAK



High input impedance (1 M Ω), low 0.9 pF input capacitance and an extensive set of probe tips and ground accessories make these low-cost single-ended probes ideal for a wide range of applications. The ZS Series is available up to 4 GHz bandwidth.

Differential Probes (200 MHz – 1.5 GHz)

ZD1500, ZD1000, ZD500, ZD200 AP033 High bandwidth, excellent common-mode rejection ratio (CMRR) and low noise make these active differential probes ideal for applications such as automotive electronics and data communications. AP033 provides 10x gain for high-sensitivity measurement of series/shunt resistor voltages.

Active Voltage/Power Rail Probe RP4030



Specifically designed to probe a low impedance power/voltage rail. The RP4030 has 30V built-in offset adjust, low attenuation (noise), and high DC input impedance with 4 GHz of bandwidth and a wide assortment of tips and leads, including solder-in and U.FL receptacle connections.

High Voltage Fiber Optically-isolated Probe HVF0103



The HVF0103 is a compact, simple, affordable probe for measurement of small signals (gate-drives, sensors, etc.) floating on an HV bus in power electronics designs, or for EMC, EFT, ESD, and RF immunity testing sensor monitoring. Suitable for up to 35kV common-mode. 140 dB CMRR.

HVD Series High Voltage Differential Probes

HVD3102, HVD3106 (1 kV) HVD3206 (2 kV) HVD3605 (6 kV) Available with 1, 2 or 6kV common-mode ratings. Excellent CMRR (65 dB @ 1 MHz) at high frequencies is combined with low inherent noise, wide differential voltage range, high offset voltage capabilities, and 1% gain accuracy. The ideal probe for power conversion system test.



HVP120, PPE4KV, PPE5KV, PPE6KV



The HVP and PPE Series includes four fixed-attenuation probes covering a range from 1 kV to 6 kV. These probes are ideal for lightning/surge or EFT testing, or for probing in-circuit beyond the range of a LV-rate passive probe.

Differential Amplifier

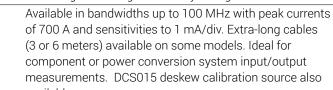
DA1855A DXC100A, DXC200 DXC-5100, DA101



The DA1855A is a stand-alone high performance 100 MHz differential amplifier with 100 dB CMRR and HV common-mode when combined with a suitable probe pair (sold separately). It is ideal for semiconductor device conduction/switching loss or high sensitivity voltage measurements.

Current Probes

CP030, CP030-3M, CP030A CP031, CP031A CP150, CP150-6M CP500, DCS015



Probe and Current Sensor Adapters

TPA10, TPA10-QUADPAK CA10, CA10-QUADPAK





TPA10 adapts supported Tektronix TekProbe-compatible probes to Teledyne LeCroy ProBus interface. CA10 is a programmable adapter for third-party current sensors that have voltage or current outputs proportional to measured current. QUADPAKs of four pieces each are available.



v :	HD04024A	HD04034A	HDO4054A	HDO4104A	
Vertical - Analog Channels	HDO4024A-MS	HD04034A-MS	HDO4054A-MS	HD04104A-MS	
Bandwidth @ 50 Ω (-3 dB)	200 MHz	350 MHz	500 MHz	1 GHz	
Rise Time (10–90%, 50 Ω) Input Channels	1.75 ns	1 ns	700 ps	450 ps	
Vertical Resolution	4 12-bits; up to 15-bits with enhanced resolution (ERES)				
Effective Number of Bits (ENOB)	8.8 bits	8.7 bits	8.6 bits	8.4 bits	
Vertical Noise Floor	0.0 Dit3	0.7 bits	0.0 bits	0.4 Dit3	
1 mV/div	70 μVrms	85 μVrms	100 μVrms	145 μVrms	
2 mV/div	70 µVrms	85 µVrms	100 μVrms	145 µVrms	
5 mV/div	75 µVrms	90 μVrms	105 µVrms	150 µVrms	
10 mV/div	80 µVrms	95 μVrms	110 µVrms	155 μVrms	
20 mV/div	100 μVrms	110 μVrms	130 µVrms	185 µVrms	
50 mV/div	195 µVrms	210 µVrms	265 µVrms	275 μVrms	
100 mVdiv	340 µVrms	360 µVrms	450 µVrms	500 μVrms	
200 mV/div	1.00 mVrms	1.10 mVrms	1.25 mVrms	1.75 mVrms	
500 mV/div	1.90 mVrms	2.10 mVrms	2.60 mVrms	2.75 mVrms	
1 V/div	3.40 mVrms	3.70 mVrms	4.50 mVrms	4.90 mVrms	
Sensitivity	50 Ω: 1 mV/div-1 V/div, fully	variable; 1 M Ω : 1 mV/div-10) V/div, fully variable		
DC Vertical Gain Accuracy	\pm (0.5%) F.S, offset at 0 V				
(Gain Component of DC Accuracy)					
Channel-Channel Isolation	DC-200 MHz:	DC-200 MHz:	DC-200 MHz:	DC-200 MHz:	
	60 dB (>1000:1),	60 dB (>1000:1),	60 dB (>1000:1),	60 dB (>1000:1),	
	(For any two input	200 MHz up to rated BW:	200 MHz up to	200-500 MHz: 50 dB	
	channels, same V/div	50 dB (>300:1),	rated BW: 50 dB (>300:1),	(>300:1), 500 MHz up to	
	settings, typical)	(For any two input channels, same V/div	(For any two input channels, same V/div	rated bandwidth:	
		settings, typical)	settings, typical)	40 dB (>100:1) (For any two input	
		settings, typical)	settings, typical)	channels, same V/div	
				settings, typical)	
Offset Range	50 Ω· 1 mV - 4 95 mV· +1 6 \	/ 5 mV - 9 9 mV · +4 V 10 mV	- 19.8 mV: ±8 V, 20 mV - 1 V: ±		
ondernange			- 19.8 mV: ±8 V, 20 mV - 100 n		
		V, 200 mV - 1 V: ±160 V, 1.02		- ,	
DC Vertical Offset Accuracy	$\pm (1.0\% \text{ of offset setting} + 0.5\% \text{FS} + 0.02\% \text{ of max offset} + 1 \text{mV})$				
Maximum Input Voltage	50Ω : 5 Vrms, 1 MΩ: 400 V max (DC + Peak AC ≤ 10 KHz)				
Input Coupling	50 Ω: DC, GND; 1 MΩ: AC, DC, GND;				
Input Impedance	50 Ω ± 2.0%;1 MΩ ± 2.0% 16 pF,				
Bandwidth Limiters	20 MHz, 200 MHz				
Horizontal - Analog Channels					
	Deal times Dell Deaders late	decided Committee (DIC) Comm			
Acquisition Modes Time/DIvision Range		rleaved Sampling (RIS), Sequestandard memory (up to 2.5			
Time/Division Range		Standard memory (up to 2.5 Roll Mode available at ≥ 100 r			
Clock Accuracy	± 2.5 ppm + 1.0ppm/year fro		11S/UIV anu ≤ 5 IVIS/S		
Sample Clock Jitter	Up to 10 ms acquired time ra		phase reference)		
Delta Time Measurement Accuracy	op to 10 ms acquired time ra	ange. 200 Isimis (internal time	ebase reference)		
Delta Time Weasurement Accuracy	$\sqrt{2} * \left(\frac{\text{Noise}}{\text{Noise}} \right)^2 + (Sa)$	ample Clock litter)2 (RMS) + (cl	lock accuracy * reading) (seconds		
	$\sqrt{\frac{SlewRate}{}}$	ample clock citter, (mile, i for	reading, teachias		
Jitter Measurement Floor	,				
Jitter Measurement Floor	$\int \int Noise $ $\Big \Big \Big$	mple Clock Jitter)² (RMS, seco	nde TIE)		
	$\sqrt{\frac{SlewRate}{}}$	Triple Clock Sitter)- (Hivis, Seco	ilus, IIL)		
litter Determine Observation	, , ,	TIE + min - IV Dinital Ob - male	050 (
Jitter Between Channels			350 ps (maximum) between a	any two channels	
Observed Observed Devidence Deviden			nalog and any digital channel		
Channel-Channel Deskew Range	±9 x time/div. setting, 100 m				
External Timebase Reference (Input)	10 MHz ±25 ppm at 0 to 10 o		farana hairar waad (intama) a		
External Timebase Reference (Output)	10 MHZ, 2.0 dBm ±1.5 dBm,	sinewave synchronized to rei	ference being used (internal or	external reference)	
Acquisition - Analog Channels					
Sample Rate (Single-shot)	10 GS/s on all 4 Channels with Enhanced Sample Rate				
Sample Rate (Repetitive)		repetitive signals (20 ps/div	to 10 ns/div)		
Memory Length			terleaved) (10,000 segments)		
(# of Segments in Sequence Mode)		for all channels, 50 Mpts (inte			
Intersegment Time	1 μS				
Averaging	Summed averaging to 1 milli	on sweeps; continuous avera	aging to 1 million sweeps		
Enhanced Resolution (ERES)	From 12.5- to 15-bits vertical		<u> </u>		
Envelope (Extrema)	Envelope, floor, or roof for up	to 1 million sweeps			
Interpolation	Linear or Sin x/x (2 pt and 4)	ot); 5 or 10 GS/s Enhanced Sa	ample Rate defaults to 2 pt or	4 pt Sin x/x respectively	

HD04024A



HDO4104A

HDO4054A

HD04024A-MS HD04034A-MS **HDO4054A-MS** HD04104A-MS Vertical, Horizontal, Acquisition - Digital Channels (with HDO4000A-MS only) 16 Digital Channels Input Channels Threshold Groupings Pod 2: D15 - D8, Pod 1: D7 - D0 TTL, ECL, CMOS (2.5 V, 3.3 V, 5 V), PECL, LVDS or User Defined Threshold Selections Maximum Input Voltage ±30V Peak ±(3% of threshold setting + 100mV) Threshold Accuracy Input Dynamic Range ± 20V Minimum Input Voltage Swing 400mV Input Impedance (Flying Leads) 100 kΩ || 5 pF Maximum Input Frequency 250 MHz Sample Rate 1.25 GS/s Record Length Standard: 12.5 MS (25 MS interleaved) - 16 Channels 25 MS (50 MS interleaved) - 16 Channels Optional -L: Minimum Detectable Pulse Width 2 ns Channel-to-Channel Skew 350 ps User Defined Threshold Range ±10 V in 20 mV steps User Defined Hysteresis Range 100 mV to 1.4 V in 100 mV steps **Triggering System** Normal, Auto, Single, and Stop Modes Any input channel, External, Ext/10, or line; slope and level unique to each source (except for line trigger) Sources Coupling DC, AC, HFRej, LFRej Pre-trigger Delay 0-100% of memory size (adjustable in 1% increments of 100 ns) Post-trigger Delay 0-10,000 Divisions in real time mode, limited at slower time/div settings or in roll mode From 2 ns up to 20 s or from 1 to 99,999,999 events Hold-off Trigger and Interpolator Jitter ≤ 4 ps rms (typical) ≤ 4 ps rms (typical) ≤ 3.5 ps rms (typical) ≤ 3.5 ps rms (typical) Internal Trigger Level Range ±4.1 div from center (typical) External Trigger Input Range Ext: ±400 mV, Ext/10: ±4 V 1,000,000 waveforms/sec (in Sequence Mode, up to 4 channels) Maximum Trigger Rate 0.9 division: 10 MHz Trigger Sensitivity with Edge Trigger 0.9 division: 10 MHz 0.9 division: 10 MHz 0.9 division: 10 MHz (Ch 1-4)1.0 divisions: 200 MHz 1.0 divisions: 200 MHz 1.0 divisions: 200 MHz 1.0 divisions: 200 MHz 2.0 divisions: 350 MHz 1.5 divisions: 250 MHz 1.5 divisions: 500 MHz 2.0 divisions: 500 MHz 2.0 divisions: 1 GHz Trigger Sensitivity with Edge Trigger 0.9 division: 10 MHz 0.9 division: 10 MHz 0.9 division: 10 MHz 0.9 division: 10 MHz (External Input) 1.0 divisions: 200 MHz 1.0 divisions: 200 MHz 1.0 divisions: 200 MHz 1.0 divisions: 200 MHz 2 2.0 divisions: 350 MHz 1.5 divisions: 250 MHz 1.5 divisions: 500 MHz 2.0 divisions: 500 MHz 2.0 divisions: 1 GHz Max. Trigger Frequency, Smart Trigger 200 MHz 350 MHz 500 MHz 1 GHz **Trigger Types** Edge Triggers when signal meets slope (positive, negative, or either) and level condition Triggers on positive or negative glitches with selectable widths. Minimum width 1.5ns, Maximum width: 20 s Width Triggers on positive or negative glitches with selectable widths. Minimum width 1.5ns, Maximum width: 20 s Glitch Window Triggers when signal exits a window defined by adjustable thresholds Logic combination (AND, NAND, OR, NOR) of up to 5 inputs (4 channels and external trigger input). Each source can be Pattern high, low, or don't care. The High and Low level can be selected independently. Triggers at start or end of the pattern. TV-Composite Video Triggers NTSC or PAL with selectable line and field; HDTV (720p. 1080i, 1080p) with selectable frame rate (50 or 60 Hz) and Line; or CUSTOM with selectable Fields (1-8), Lines (up to 2000), Frame Rates (25, 30, 50, or 60 Hz), Interlacing (1:1, 2:1, 4:1, 8:1), or Synch Pulse Slope (Positive or Negative) Runt Trigger on positive or negative runts defined by two voltage limits and two time limits. Select between 1 ns and 20 ns Trigger on edge rates. Select limits for dV, dt, and slope. Select edge limits between 1 ns and 20 ns Slew Rate Triggers on intervals selectable between 1 ns and 20 s Interval Triggers if signal drops out for longer than selected time between 1 ns and 20 s Dropout Triggers with Exclusion Technology Glitch, Width, Interval, Runt, Slew Rate - Trigger on intermittent faults by specifying the expected behavior and triggering when that condition is not met **Qualified** Triggers on any input source only if a defined state or edge occurred on another input source. Delay between sources is selectable by time or events. (Note: event B pattern trigger cannot include analog channels). (Timeout or State/Edge Qualified) Low Speed Serial Protocol Trigger I2C, SPI (SPI, SSPI, SIOP), UART-RS232, CAN1.1, CAN2.0, CAN FD, LIN, FlexRay, MIL-STD-1553, AudioBus (I2S, LJ, (Optional) RJ, TDM), USB1.x/2.0

HDO4034A



	HDO4024A HDO4024A-MS	HDO4034A HDO4034A-MS	HDO4054A HDO4054A-MS	HD04104A HD04104A-MS
Measurement Tools	ПDU4024A-IVI3	HD04034A-WS	HDU4034A-IVI3	HD04104A-W3
Measurement Functionality	Display up to 8 measurement parameters together with statistics, including mean, minimum, maximum, standard deviation, and total number. Each occurrence of each parameter is measured and added to the statistics table. Histicons provide a fast, dynamic view of parameters and wave shape characteristics. Parameter gates define the location for measurement on the source waveform.			
Measurement Parameters - Horizontal + Jitter	Delay (from trigger, 50%), Duty Cycle (50%, @level), Edges (@level), Fall Time (90-10, 20-80), Frequency (50%, @level), Period (50%, @level), Δ Period (@level), Phase (@level), Rise Time (10-90, 20-80), Skew, Time (@level), Δ Time (@level), Width+, Width-			
Measurement Parameters - Vertical		, Mean, Minimum, Peak-to-Pea		
Measurement Parameters - Pulse	Area, Base, Fall Time (90-10), 80-20), Overshoot (positive,	negative), Rise Time (10-90, 8	30-20), Top, Width+, Width-
Math Tools				
Math Functionality		ons traces (F1-F2). The easy-to n trace, and function traces can		
Math Operators - Basic Math	Average (summed), Average (continuous), Difference (–), Envelope, Floor, Invert (negate), Product (x), Ratio (/), Reciprocal, Rescale (with units), Roof, Sum (+).			
Math Operators - Filters	Enhanced resolution (to 15 bits vertical)			
Math Operators - Frequency Analysis	FFT (power spectrum, mag and Blackman Harris windo	nitude), up to full record length ws.	. Select from Rectangular, Vc	onHann, Hamming, FlatTop
Math Operators - Functions	Absolute value, Derivative, I (identity).	ntegral, Invert (negate), Recipro	ocal, Rescale (with units), Squ	uare, Square root, Zoom
Measurement and Math Integration	ion			
	Trend (datalog) of up to 1 m	nillion measurement paramete	S.	
Pass/Fail Testing				
Pass/Fail Testing		ser-defined mask, waveform A op, Alarm, (send) Pulse, Hardo abNotebook.		
Display System				
Display Size	Color 12.1" widescreen flat	panel TFT-Active Matrix with h	igh resolution touch screen	
Display Resolution	WXGA; 1280 x 800 pixels			
Number of Traces		aces. Simultaneously display o		h, and X-Y traces
Grid Styles	Auto, Single, Dual, Quad, Octal, Tandem, Quattro, X-Y, Single+X-Y, Dual+X-Y			
Waveform Representation	Sample dots joined, or sam	ple dots only		



	HDO4024A HDO4024A-MS	HD04034A HD04034A-MS	HD04054A HD04054A-MS	HD04104A HD04104A-MS
Processor/CPU				
Type	Intel® Core™ i3-2330E Dual,	2.2 GHz (or better)		
Processor Memory	8 GB standard standard	,		
Operating System	Microsoft Windows® 7 Pro 6	64-Bit Embedded		
Oscilloscope Operating Software	Teledyne LeCroy MAUI™ wit	h OneTouch		
Connectivity				
Ethernet Port	Supports 2 10/100/1000Ba	seT Ethernet interface (RJ45	ports)	
USB Host Ports	Minimum 6 total (incl. 2 fror	nt panel) USB 2.0 ports suppo	rt Windows compatible devic	es
USB Device Port	1 USBTMC port			
GPIB Port (Optional)	Supports IEEE - 488.2 (Exte			
External Monitor Port	monitor. Includes support fo	ctor and 15 pin D-Type WXGA or extended desktop operatior external monitor (Note: exterr	n with WXGA resolution on se	cond monitor. Supports
Remote Control		r via Teledyne LeCroy Remote		ou toudit dorect unver).
Probes				
Standard Probes	Qty. (4) ÷10 Passive Probes			
Probing System		cts and supports a variety of	compatible probes	
Power Requirements				
Voltage	100-240 VAC ±10% at 45-6 Category 300 V CAT II	6 Hz; 110-120 VAC ±10% at 3	80-420 Hz; Automatic AC Vol	tage Selection; Installation
Power Consumption (Nominal)	200 W / 200 VA			
Max Power Consumption		peripherals and active probes	s connected to 4 channels)	
Environmental				
Temperature	Operating: 5 °C to 40 °C; No	n-Operating: -20 °C to 60 °C		
Humidity	Operating: 5% to 90% relativ (non-condensing) at +40 °C	e humidity (non-condensing)		•
Altitude		ft) max at +30 °C; Non-Opera		
Random Vibration	Operating: 0.31 g _{rms} 5 Hz to	500 Hz, 15 minutes in each oz to 500 Hz, 15 minutes in each	of three orthogonal axes;	
Functional Shock		e, 3 shocks (positive and negative		xes, 18 shocks total
Physical				
Dimensions (HWD)		(291.7 mm x 399.4 mm x 131	.31 mm)	
Weight	12.9 lbs. (5.86 kg.)			
Certifications				
CE Certification UL and cUL Listing	CE Compliant, UL and cUL li UL 61010-1 (3rd Edition), UL CAN/CSA C22.2 No.61010-	61010-2-030 (1st Edition) 1-12		
	CE Compliant, UL and cUL li UL 61010-1 (3rd Edition), UL CAN/CSA C22.2 No.61010-	61010-2-030 (1st Edition)		
Warranty and Service				
-	3-year warranty; calibration upgrades, and calibration se	recommended annually. Option	onal service programs include	e extended warranty,

ORDERING INFORMATION



Product Code

Product Description HDO4000A Oscilloscopes	Product Code
200 MHz, 10 GS/s, 4 Ch, 12.5 Mpts/Ch 12-bit HD	HD04024A
Oscilloscope with 12.1" WXGA Touch Display	
350 MHz, 10 GS/s, 4 Ch, 12.5 Mpts/Ch 12-bit HD	HD04034A
Oscilloscope with 12.1" WXGA Touch Display	
500 MHz, 10 GS/s, 4 Ch, 12.5 Mpts/Ch 12-bit HD	HD04054A
Oscilloscope with 12.1" WXGA Touch Display	
1 GHz, 10 GS/s, 4 Ch, 12.5 Mpts/Ch 12-bit HD	HD04104A
Oscilloscope with 12.1" WXGA Touch Display	
HDO4000A-MS Mixed Signal Oscilloscopes	
200 MHz, 10 GS/s, 4+16ch, 12.5 Mpts/Ch 12-bit HD	HD04024A-MS
Mixed Signal Oscilloscope w/ 12.1" WXGA Color Displ	av
350 MHz, 10 GS/s, 4+16ch, 12.5 Mpts/Ch 12-bit HD	HD04034A-MS
Mixed Signal Oscilloscope w/ 12.1" WXGA Color Displ	av
500 MHz, 10 GS/s, 4+16ch, 12.5 Mpts/Ch 12-bit HD	HD04054A-MS
Mixed Signal Oscilloscope w/ 12.1" WXGA Color Displ	
1 GHz, 10 GS/s, 4+16ch, 12.5 Mpts/Ch 12-bit HD	HD04104A-MS
Mixed Signal Oscilloscope w/ 12.1" WXGA Color Displ	ay
Included with Standard Configurations (HDO4000 HDO4000A-MS)	OA and
÷10 Passive Probe (Total of 1 Per Channel), Getting Star	ted Guide
Anti-virus Software (Trial Version), Microsoft Windows E	Embedded Standard
7 P 64-Bit License, Commercial NIST Traceable Calibrat	
Certificate, Power Cable for the Destination Country, Pro	tective Front Cover.
3-year Warranty	
L	
Included with HDO4000A-MS	. (01 00)
16 Channel Digital Leadset, Extra Large Gripper Probe Sc	
Ground Extenders (Qty. 20), Flexible Ground Leads (Qty.	3)
Memory Option	
25 Mpts/ch (50 Mpts interleaved) memory	HD04KA-L
Hardware Options	
Removable Solid State Drive Package (includes	HD04KA-RSSD
removable solid state drive kit and two solid state drive	
Additional Removable Solid State Drive	HD04KA-RSSD-02
General Accessories	
External GPIB Accessory	USB2-GPIB
Soft Carrying Case	HD04K-S0FTCASE
Rack Mount Accessory	HD04K-RACK
Accessory Pouch	HD04K-P0UCH
Local Language Overlays	
German Front Panel Overlay	HD04K-FP-GERMAN
French Front Panel Overlay	HD04K-FP-FRENCH
Italian Front Panel Overlay	HD04K-FP-ITALIAN
Spanish Front Panel Overlay	HD04K-FP-SPANISH
	DO4K-FP-JAPANESE
Korean Front Panel Overlay	HD04K-FP-KOREAN
	IDO4K-FP-CHNES-TR
	HD04K-FP-CHNES-SI
Russian Front Panel Overlay	HD04K-FP-RUSSIAN

Software Options	
Electrical Telecom Mask Test Package	HDO4K-ET-PMT
Spectrum Analysis Option	HD04K-SPECTRUM
Power Analysis Option	HD04K-PWR
Serial Data Options	
ARINC 429 Symbolic Decode Option H	IDO4K-ARINC429bus DSymbolic
Audiobus Trigger and Decode Option for	HDO4K-Audiobus TD
I ² S, LJ, RJ, and TDM	
CAN, LIN and FlexRay Trigger and Decode Op	otion HD04K-AUTO
CAN FD Trigger and Decode Option	HDO4K-CAN FDbus TD
CAN Trigger and Decode Option	HDO4K-CANbus TD
D-PHY Decode Option	HDO4K-DPHYbus D
DigRF 3G Decode Option	HDO4K-DigRF3Gbus D
DigRF v4 Decode Option	HDO4K-DigRFv4bus D
ENET Decode Option	HDO4K-ENETbus D
FlexRay Trigger and Decode Option	HDO4K-FlexRaybus TD
I ² C, SPI and UART Trigger and Decode Option	n HDO4K-EMB
I ² C Bus Trigger and Decode Option	HDO4K-I2Cbus TD
LIN Trigger and Decode Option	HD04K-LINbus TD
MDIO Decode	HDO4K-MDIObus D
Manchester Decode Option	HDO4K-Manchesterbus D
MIL-STD-1553 Trigger and Decode Option	HD04K-1553 TD
NRZ Decode Option	HD04K-NRZbus D
SENT Decode Option	HDO4K-SENTbus D
SPI Bus Trigger and Decode Option	HD04K-SPIbus TD
SPMI Decode	HDO4k-SPMIbus D
SpaceWire Decode Option	HD04K-SpaceWirebus D
UART and RS-232 Trigger and Decode Option	h HD04K-UART-RS232bus TD
USB 2.0 Trigger and Decode Option	HDO4K-USB2bus TD
USB2-HSIC Decode Option	HD04K-USB2-HSICbus D

Product Description

ORDERING INFORMATION



Product Description	Produ	uct Code
Probes and Amplifiers		
250 MHz Passive Probe for HDO4000A, 10:1, 10 MΩ		PP017
500 MHz Passive Probe 10:1, 10 MΩ		PP018
500 MHz Passive Probe, 5mm, 10:1, 10 MΩ		PP026
Power/Voltage Rail Probe. 4 GHz bandwidth, 1.2x		RP4030
attenuation, ±30V offset, ±800mV		
Browser for use with RP4030	RP4000-	BROWSER
1,500 V, 120 MHz High-Voltage Differential Probe		HVD3106
1kV, 80 MHz High Voltage Differential Probe with 6m cable	HV	D3106-6M
1kV, 120 MHz High Voltage Differential Probe with-	HVD31	06-NOACC
out tip Accessories		LIV/D0100
1,500 V, 25 MHz High-Voltage Differential Probe		HVD3102
1kV, 25 MHz High Voltage Differential Probe without tip Accessories	HVD31	02-NOACC
2kV, 120 MHz High Voltage Differential Probe		HVD3206
2kV, 80 MHz High Voltage Differential Probe with	HV	D3206-6M
6m cable		
6kV, 100 MHz High Voltage Differential Probe		HVD3605
High Voltage Fiber Optic Probe, 60 MHz (requires		HVF0103
accessory tip)		100 11/ 7/0
±1V (1x) Tip Accessory for HVF0103		100-1X-TIP
±5V (5x) Tip Accessory for HVF0103		100-5X-TIP
±20V (20x) Tip Accessory for HVF0103		00-20X-TIP
30 A; 100 MHz Current Probe – AC/DC; 30 A _{rms} , 50 A _{peak} P		CP031
30 A; 100 MHz High Sensitivity Current Probe – AC/DC; 50 A _{neak} Pulse	30 A _{rms} ;	CP031A
30 A; 50 MHz Current Probe – AC/DC; 30 A _{rms} ; 50 A _{beak} Pu	lse.	CP030
30 A; 50 MHz High Sensitivity Current Probe – AC/DC; 3		CP030A
50 A _{neak} Pulse	· · · · · · · · · · · · · · · · · · ·	0. 000, 1
150 A; 10 MHz Current Probe – AC/DC; 150 A _{ms} ; 500 A _{sea}	Pulse	CP150
500 A; 2 MHz Current Probe – AC/DC; 500 A _{rms} ; 700 A _{peak}		CP500
Deskew Calibration Source for CP031, CP030 and AP01		DCS015

Product Description	Product Code
Probes and Amplifiers (cont'd)	
500 MHz Differential Probe	AP033
200 MHz, 3.5 pF, 1 M Ω Active Differential Probe, ±20 V, 60)V ZD200
common-mode	
1 GHz, 1.0 pF, 1 M Ω Active Differential Probe, ±8 V,	ZD1000
15 OUT 10 v 5 1 MO Active Differential Dealer 10 V	701500
1.5 GHz, 1.0 pF, 1 M Ω Active Differential Probe, ±8 V, 10V common-mode	ZD1500
1 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	ZS1000
Set of 4 ZS1000	ZS1000-QUADPAK
1.5 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	ZS1500
Set of 4 ZS1500	ZS1500-QUADPAK
1 Ch, 100 MHz Differential Amplifier	DA1855A
with Precision Voltage Source	
100:1 or 10:1 Selectable, 250 MHz Passive Diff. Probe Pa	air DXC100A
1:1, 50 MHz Passive Differential Probe Pair	DXC200
100:1, 250 MHz, 2.5kV High Voltage Probe Pair	DXC5100
10x, 1 M Ω Passive Attenuator for DXC Series Probes	DA101
100:1 400 MHz 50 MΩ 1 kV High-voltage Probe	HVP120
100:1 400 MHz 50 MΩ 4 kV High-voltage Probe	PPE4KV
1000:1 400 MHz 50 MΩ 5 kV High-voltage Probe	PPE5KV
1000:1 400 MHz 50 MΩ 6 kV High-voltage Probe	PPE6KV
TekProbe to ProBus Probe Adapter	TPA10
Set of 4 TPA10 TekProbe to ProBus Probe Adapters.	TPA10-QUADPAK
Programmable Current Sensor to ProBus Adapter	CA10
for use with third party current sensors	
Set of 4 CA10 Programmable Current Sensor to	CA10-QUADPAK
ProBus Adapters for use with third party current	
sensors	

Customer Service

Teledyne LeCroy oscilloscopes and probes are designed, built, and tested to ensure high reliability. In the unlikely event you experience difficulties, our digital oscilloscopes are fully warranted for three years and our probes are warranted for one year. This warranty includes:

- No charge for return shipping
- Long-term 7-year support
- Upgrade to latest software at no charge

For more information, please contact:



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